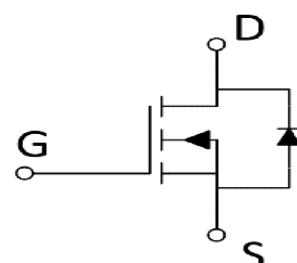
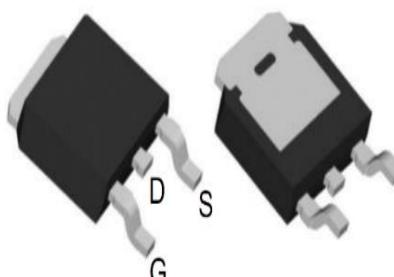


**30V<sub>DS</sub>/±20V<sub>GS</sub> N-Channel Enhancement Mode MOSFET**

## Features

- V<sub>DS</sub>=30V,I<sub>D</sub>=50A
- R<sub>DS(ON)</sub>=12mΩ (TYP.) V<sub>GS</sub>=10V
- Reliable and Rugged
- Avalanche Rated
- Low On-Resistance
- High Current Capability

TO-252



## Applications

- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion

## Ordering Information

Device	Package	Marking	Package Qty.
HMN3050A4	TO-252	Pb-Free	2500pcs/Reel

## Absolute Maximum Ratings (T<sub>C</sub>=25°C,unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V <sub>GS</sub> =0V)	V <sub>DS</sub>	30	V
Gate-Source Voltage (V <sub>GS</sub> =0V,static)	V <sub>GS</sub>	±20	V
Continuous Drain Current (T <sub>C</sub> =25°C)	I <sub>D</sub>	50	A
Continuous Drain Current (T <sub>C</sub> =100°C)		30	A
Pulses Drain Current	I <sub>DM</sub>	200	A
Maximum Power Dissipation	P <sub>D</sub>	60	W
Single pulse avalanche energy	E <sub>as</sub>	100	mJ
Operating,Storage Temperature Range	T <sub>J</sub> ,T <sub>STG</sub>	-55~175	°C

## Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V,I <sub>D</sub> =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V	-	-	1	μA
Gate -Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> ,I <sub>D</sub> =250μA	1.0	1.6	2.6	V
Drain-SourceOn-stageResistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V,I <sub>D</sub> =20A	-	9	13	mΩ
		V <sub>GS</sub> =4.5V,I <sub>D</sub> =20A	-	10	16	

## Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	-	2.5	-	°C / W

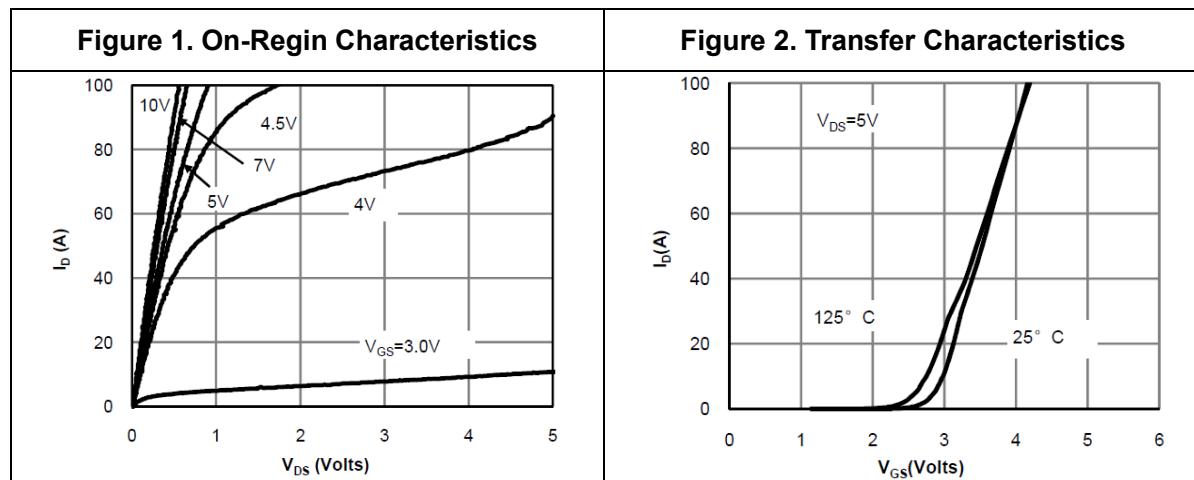
## Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$V_{DS}=15V$ $V_{GS}=0V$ $f=1MHz$	-	2000	-	pF
Output capacitance	$C_{oss}$		-	280	-	
Reverse transfer capacitance	$C_{rss}$		-	210	-	
Gate Resistance	$R_g$	$f=1MHz$ $V_{DS}=15V$ $V_{GS}=10V$ $I_D=20A$	-	1.5	-	Ω
Total Gate Charge	$Q_g$		-	32	-	nC
Gate Source Charge	$Q_{gs}$		-	4.9	-	
Gate Drain Charge	$Q_{gd}$		-	6.8	-	
Turn-on delay Time	$t_{d(on)}$	$V_{GS}=10V$ $V_{DS}=15V$ $R_L=0.75\Omega$ $R_G=3\Omega$	-	10	-	ns
Rise time	$t_r$		-	8	-	
Turn-off delay Time	$t_{d(off)}$		-	25	-	
Fall time	$t_f$		-	5	-	

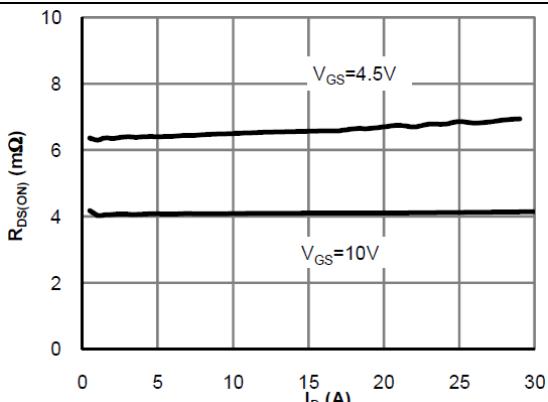
## Reverse Diode Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Body Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_{SD}=1A$	-	0.85	1.2	V
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0V, I_{SD}=20A$ $d_i/d_t=500A/\mu s$	-	27	-	ns
Reverse Recovery Charge	$Q_{rr}$		-	20	-	nC

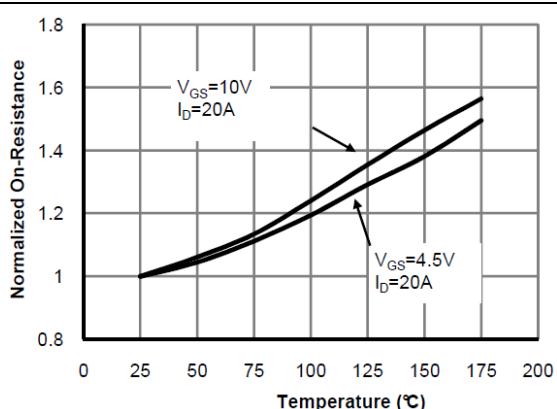
## Electrical Characteristics Diagrams



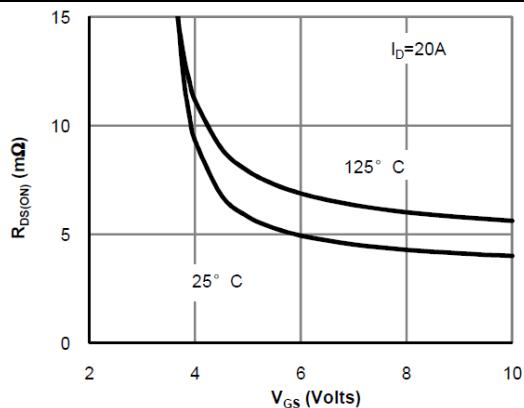
**Figure 3. On-Resistance vs. Drain Current and Gate Voltage**



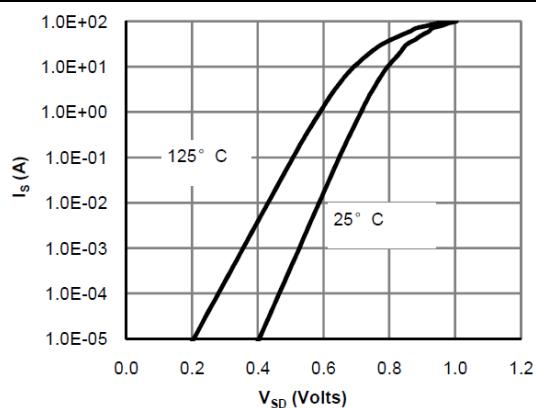
**Figure 4. On-Resistance vs. Junction Temperature**



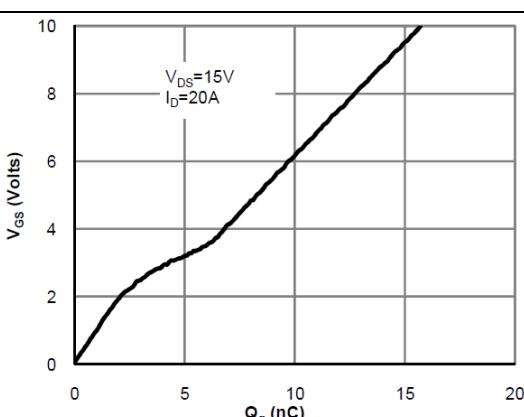
**Figure 5. On-Resistance vs. Gate-Source Voltage**



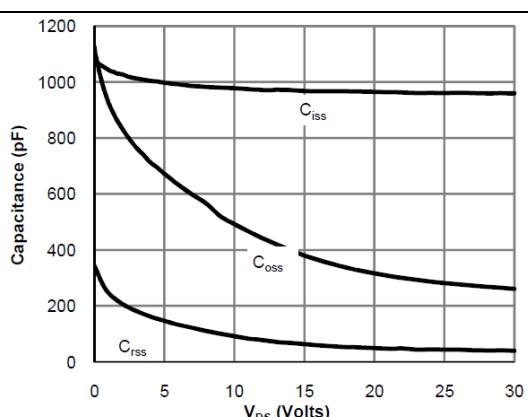
**Figure 6. Body-Diode Characteristics**



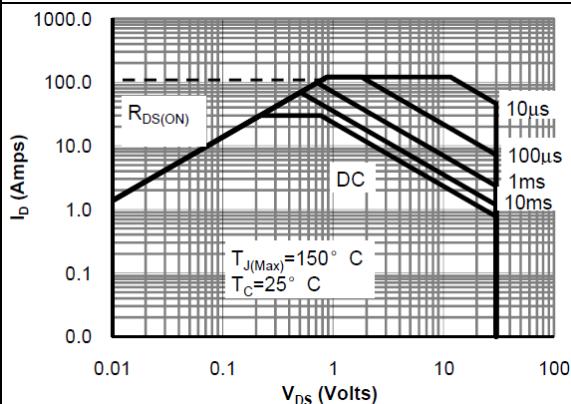
**Figure 7. Gate-Charge Characteristics**



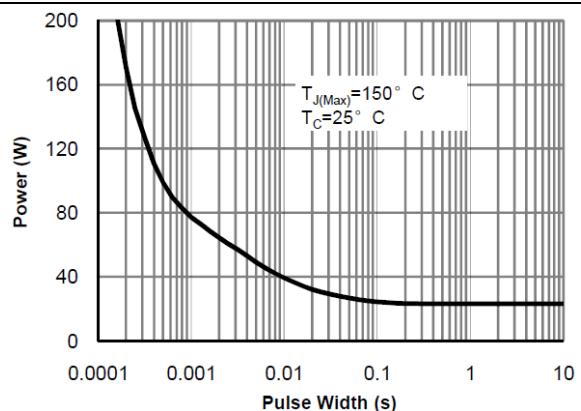
**Figure 8. Capacitance Characteristics**



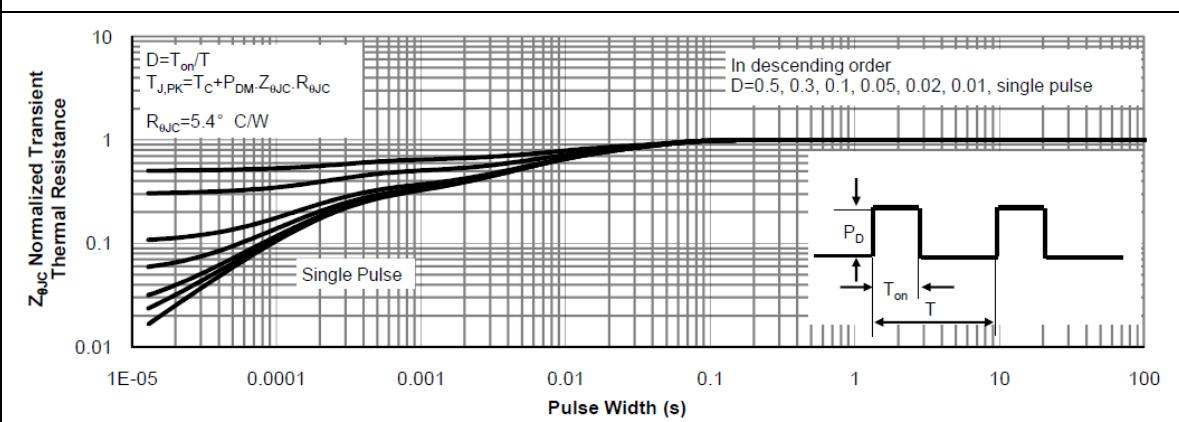
**Figure 9. Maximum Forward Biased Safe Operating Area**



**Figure 10. Single Pulse Power Rating Junction-to-Case**



**Figure 11. Normalized Maximum Transient Thermal Impedance**



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